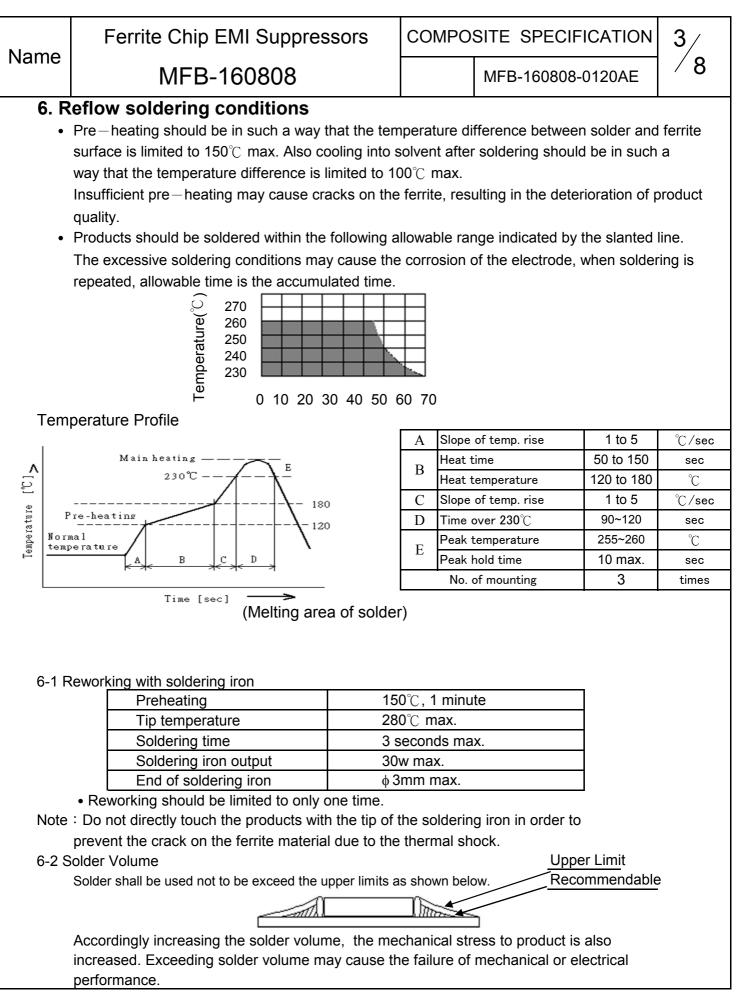
Name	Ferrite Chip EMI Suppressors MFB-160808			COMPOSITE SPE		CIFICATIO	N	1/		
Name					MFB-160	808-0120	AE	8 / 8		
	1. Scope									
This specification applies to the MFB-1608 series Ferrite Chip EMI suppressors.										
	2. Standard and	Atmospher	ic Condit	ions						
	Unless otherwise	specified the s	standard rai	nge of atm	ospheric c	onditions f	or			
making measurements and tests is as follows:										
Ambient temperature : 20±15℃										
	Relative humidity	: 30~70%								
	If there may be a	ny doubt on the	e results, m	easureme	nts shall be	e made wit	hin			
	the following limit	S:								
	Ambient tempera	ture : 25±5 ℃								
	Relative humidity	: 30~70%								
	3. Ratings									
						•	*			
	PART NO	IMPEDANCE (Ω)		DC RESISTANCE		RATED CURRENT		ENT		
		AT100 MHz 500mV		(Ω) Max		(mA) Max		(
М	MFB-160808-0120AE 120±25%		0.15		400					
%The maximum rated current : the DC current value having temperature increased 40 $^\circ C$ after thru DC current 2 hours at ambient temperature.										
4. Dimensions										
OPERATING TEMP. RANGE : -55℃ ~ +125℃										
	STORAGE TEMP. RANGE : -40°C ~ +85°C					1				
		uniti	TYPE	L 1.6±0.15	W 0.8±0.15	T	<i>ہ</i> ~0.2			
		mm (inch)	MFB-1608		(0.031±0.006)	0.8±0.15 (0.031±0.006)	~2.0 ~0.008			

5. The Place of Origin :

Taichung, Taiwan

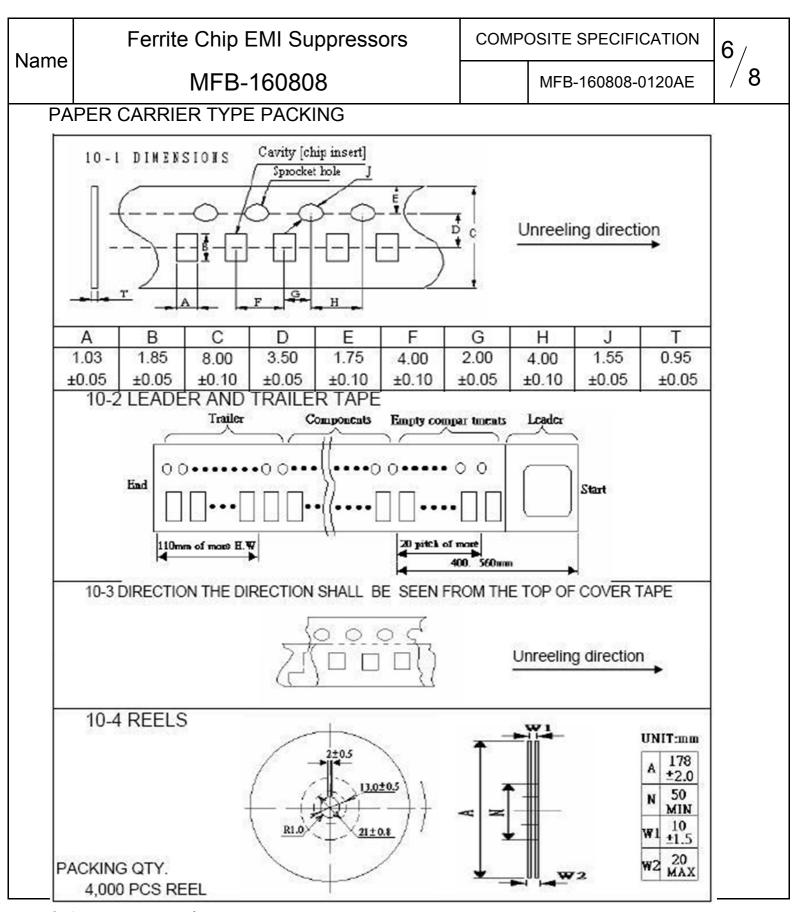
PLANNED BY	CHECKED BY	APPROVED BY
LUN	TINA	Chi Chi Huang

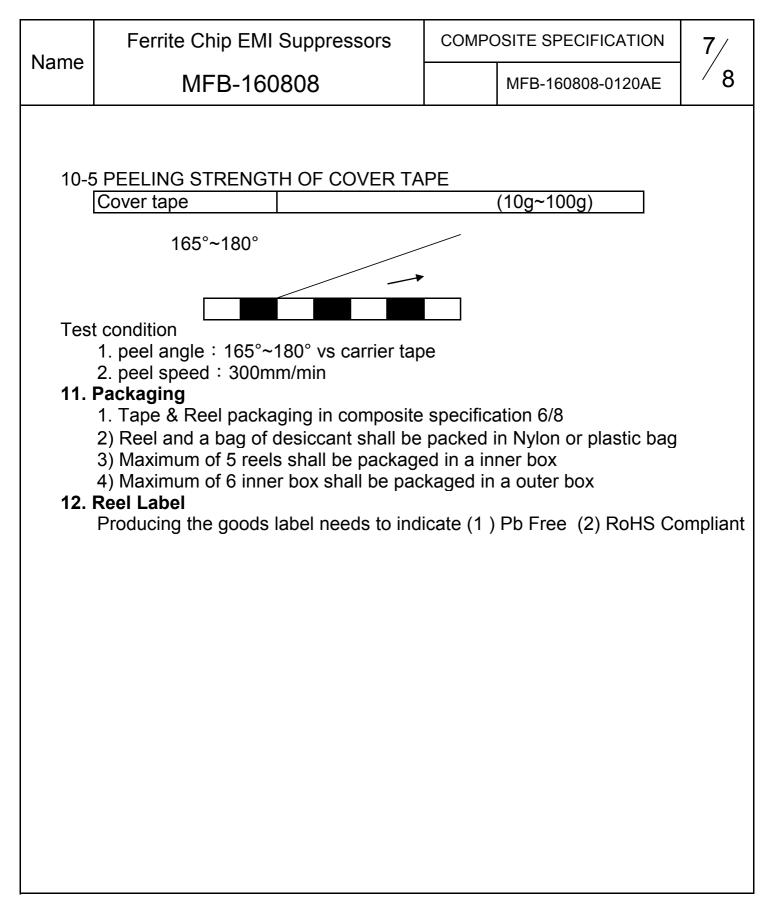
Ferrite Chip EMI Suppressors 2/8 COMPOSITE SPECIFICATION Name MFB-160808 MFB-160808-0120AE 200 160 Impedance (Ω) 80 R X 40 ١ 0 ¹⁰ Frequency (MHz) 100 1000



lama	Ferrite Chip EMI Suppressors		COMPOSITE SPECIFICATION	4 /		
MFB-160808		MFB-160808	MFB-160808-0120AE	8		
 7. Equipment 7-1 IMPEDANCE Impedance shall be measured with HP-4286A impedance analyzer or equivalent system 7-2 DC RESISTANCE DC resistance shall be measured using HP 4338 digital mili – ohm meter with 4 terminal method. 8. Mechanical Characteristics 						
	TEM	Specification	Test Conditions			
Terminal Strength		Terminal strength does not distort the case shall meet SPEC DC resistance specifications.	C DC Solder chip on PCB and applied 10N (1.02Kgf) for 10 sec			
	bstrate ding Test	SPEC substrate bending test DC resistance shall meet specifications.	After soldering a chip to a test substrate, bend the substrate by 3mm hold for 10s and then return. Soldering shall be done in accordance with the recommended PC board pattern and reflow soldering.			
Resistance to Solder Heat No visible damage Electrical characteristics and mechanical characteristics shall be satisfied. Consult standard MIL-STD-202 METHOD 210		Electrical characteristics and mechanical characteristics shall be satisfied. Consult standard MIL-STD-202	Solder Temp. : $265\pm3^{\circ}$ C Immersion time : 6 ± 1 sec Preheating : 100° C to 150° C, 1 minute. Measurement to be made after keeping at room temp for 24 ± 2 hrs. Solder : Sn-3Ag-0.5Cu			
Solderability 95% min. coverage of all metabolised area Consult standard J-STD-002			Solder temp. : 240±5℃ Immersion time : 3±1 sec Solder : Sn-3Ag-0.5Cu			

MF-B-16080/8 MFE-160808-0120AE 7 • 9. ReLINITY AND TEST CONDITIONS 9. Performance specification 1. Appearance: no mechanical damage 2. Impedance shall be with ±30% of the initial value 5. Test condition 1. Temperature: 125° ±2° 2. Testing time: 1000±12/ms 3. Measurement: After placing at room ambient temperature for 24 hours minimum 9-2 Blazed Humidity RESISTANCE 3. Measurement: After placing at room ambient temperature for 24 hours minimum 9-2 Blazed Humidity RESISTANCE 3. Temperature: 125° ±2° 3. Testing time: 1000±12/ms 3. Temperature: 35° ±2° 3. Temperature: 35° ±2° 3. Temperature: 35° ±2° 3. Temperature: 35° ±2° 3. Testing time: 1000±12 hours 4. Measurement: After placing at room ambient temperature for 24 hours minimum 9-3 TEEMPERATURE CYCLE a. Performance specification 1. Appearance: no mechanical damage 2. Impedance shall be with ±30% to the initial value b. Test condition 1. Appearance: no mechanical damage 2. Impedance shall be with ±30% to the initial value b. Test condition 1. Appearance: no mechanical damage 2. Impedance shall be with ±30% to the initial value b. Test condition 1. Appearance: no mechanical damage 2. Impedance shall be with ±30% to the initial value b. Test condition 1. Appearance: no mechanical damage 2. Impedance: no mechanical damage 2. Impedance: no mechanical damage 2	Name Ferrite Chip EMI Suppressors COMPOS		OSITE SPECIFICATION	5/	
 9-1 HIGH TEMPERATURE RESISTANCE a. Performance specification 1. Appearance: no mechanical damage 2. Impedance shall be with ±30% of the initial value b. Test condition 1. Temperature: 125 © ±2 © 2. Testing time: 10000±12/hs 3. Measurement: After placing at room ambient temperature for 24 hours minimum 9-2 Biased Humidity RESISTANCE a. Performance specification 1. Appearance at the with ±30% of the initial value b. Test condition 1. Temperature: 55 © ±2 © 3. Testing time: 1000 ± 12 hours 4. Measurement: After placing at room ambient temperature for 24 hours minimum 9-3 TEMPERATURE CYCLE a. Temperature: 55 © ±2 © 3. Testing time: 1000 ± 12 hours 4. Measurement: After placing at room ambient temperature for 24 hours minimum 9-3 TEMPERATURE CYCLE a. Temperature: 55 © ±5 © the place of the initial value b. Test condition 1. Low Temperature: 125 © ±5 © the place of 30 minutes each 2. Hingedance shall be with ±30% of the initial value b. Test condition 1. Low Temperature: 125 © ±5 © the place of 30 minutes each 2. Hingedance shall be with ±30% of the initial value b. Test condition 1. Low Temperature: 125 © ±5 © the place of 30 minutes each 2. Hingedance shall be with ±30% of the initial value b. Test condition 1. Parearance: 125 © ±50 © this minutes step2. Room temperature 206 minutes step3. TeST temps5 © 30.43 minutes step4. TeST a. Performance specification 1. Appearance is no mechanical damage 2. Impedance shall be with ±30% of the initial value b. Test condition 1. Appearance is no mechanical damage 2. Impedance shall be with ±30% of the initial value b. Test condition 1. Appearance is no mechanical damage 3. Measurement: Af	INGILLE	MFB-160808		MFB-160808-0120AE	8 \
 1.peak acceleration : 100 g's 2.Duration of pulse : 6 ms 3.Waveform : Half-sine 4.Velocity change : 12.3 ft/sec 5. Direction : X ' Y ' Z (3axes/3 times) 9-6 Operational Life a. Performance specification 1.Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial value b.Test condition 1.Temperature: 125°C ±2°C 2.Testing time : 1000±12hrs 3.Measurement : After placing at room ambient temperature for 24 hours minimum 9-7 Electrostatic discharge test a. Performance specification 1.Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial value 	 9-1 HIGH TEMPERATURE RESISTANCE a. Performance specification 1. Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial value b. Test condition 1. Temperature: 125℃ ±2℃ 2. Testing time : 1000±12hrs 3.Measurement : After placing at room ambient temperature for 24 hours minimum 9-2 Biased Humidity RESISTANCE a. Performance specification 1. Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial value b. Test condition 1. Humidity: 85 ± 5%RH 2. Temperature: 85℃ ±2℃ 3. Testing time: 1000 ± 12 hours 4. Measurement : After placing at room ambient temperature for 24 hours minimum 9-3 TEMPERATURE CYCLE a. Performance specification 1. Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial value 9-3 TEMPERATURE CYCLE a. Performance specification 1. Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial value b. Test condition 1. Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial value b. Test condition 1. Low Temperature: 155℃ ±5℃ kept stabilized for 30 minutes each 2. High Temperature: 125℃ test test bilized for 30 minutes each 2. Civcle : 1000 cvcles 3. Measurement : After placing for 24hours minimum at room ambient temperature 4. step155℃ test ±50 minutes step3. +125℃ test ±150 minutes step3. +125℃ test ±150 minutes step4. room temperature 2105 minutes step4. Room temperature 1250 timutes step4. Room temperature				
2.Mode 1:150 pF/330 Ohm 3.Mode 2:150 pF/2000 Ohm		 3.Waveform : Half-sine 4.Velocity change : 12.3 ft/sec 5. Direction : X , Y , Z (3axes/3 times) 9-6 Operational Life a. Performance specification 1.Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial b.Test condition 1.Temperature: 125°C ±2°C 2.Testing time : 1000±12hrs 3.Measurement : After placing at room ambient to 9-7 Electrostatic discharge test a. Performance specification 1.Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial b.Test condition 1.Appearance : no mechanical damage 2. Impedance shall be with ±30% of the initial b.Test condition 1.ESD voltage: 15k volts 2.Mode 1:150 pF/330 Ohm 	emperature f	for 24 hours minimum	





NAME	Ferrite Chip EMI Suppressors	COMPOSITE SPECIFICATION		8 /			
	MFB-160808		MFB-160808-0120AE	/ 8			
13.	13. Storage						
 13. Storage 13-1The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Packages must be stored at 40°C or less and 70% RH or less. 13-2 The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust or harmful gas (hydrogen chloride, sulfurous acid gas or hydrogen sulfide). 13-3 Packaging material may be deformed if packages are stored where they are extored where they are exposed to heat or direct sun – light. 13-4 Minimum packages, such as polyvinyl heat—seal packages shall not be opened until just before they are used. If opened, use the reels as soon as possible. 13-5 Solderability specified in composite specification 4/8 shall be for 6 months from the date of delivery on condition that they are stored at the environment specified clause 							
	For those parts which passed more than 6 m be checked solderability before it is used.	onths shall					
14. Quality System							
 ■ ISO/TS16949 ■ IECQ QC 080000 							